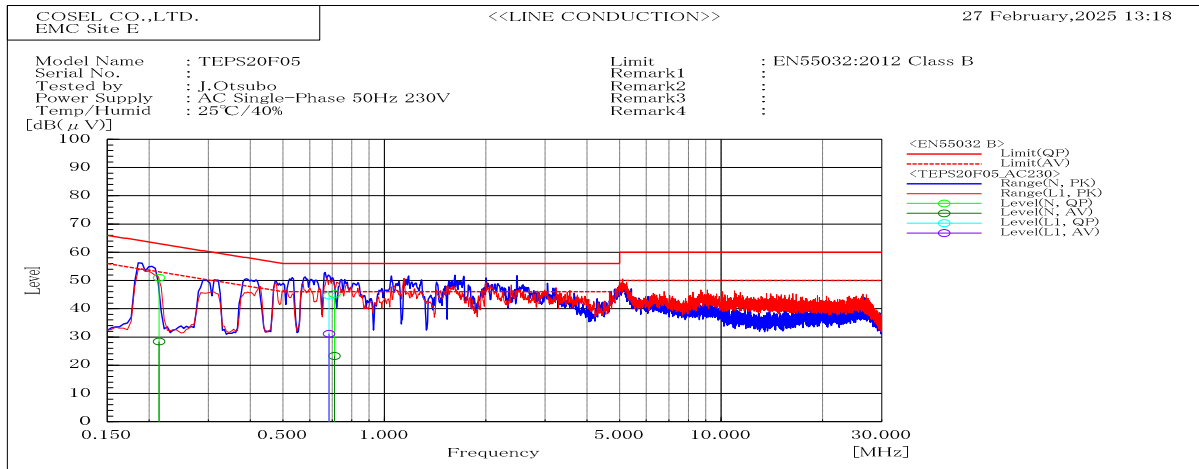
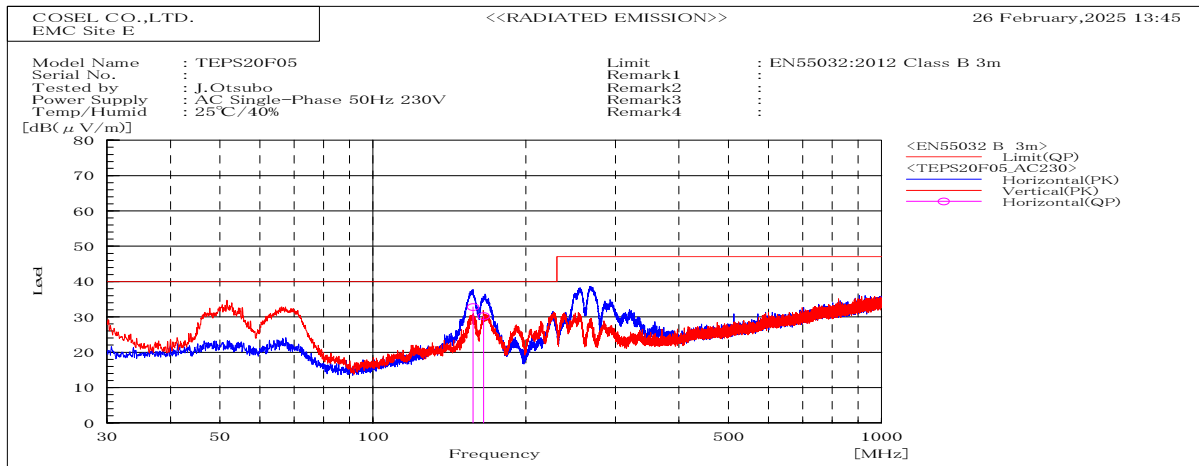


DATA SHEET		Date	24-Mar-25
Model	TEPS20F05	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma



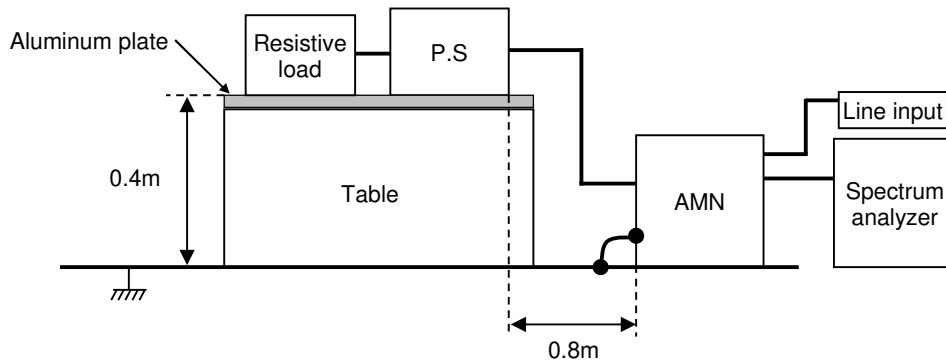
Frequency	Line	Level		Limit		Margin		Pass/Fail	Remark
MHz		dB(μV)		dB(μV)		dB			
		QP	AV	QP	AV	QP	AV		
0.685	L1	44.7	31.2	56	46	11.3	14.8	Pass	
0.71	N	45.2	23.3	56	46	10.8	22.7	Pass	
0.214	N	51	28.4	63	53	12	24.6	Pass	



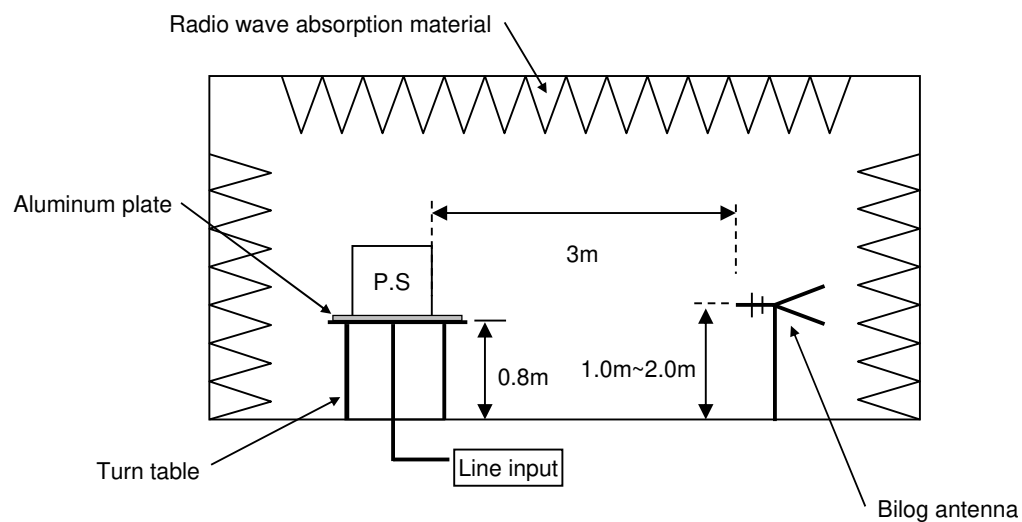
Frequency	Polarization	Stability	Level	Limit	Margin	Pass/Fail	Height	Angle	Remark
MHz			dB(μV/m)	dB(μV/m)	dB				
			QP	QP	QP		cm	deg	
157.412	H	Stable	32.8	40	7.2	Pass	188	0	
165.173	H	Stable	30.2	40	9.8	Pass	177.7	19.9	

DATA SHEET		Date	24-Mar-25
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma

### 1. Line conduction



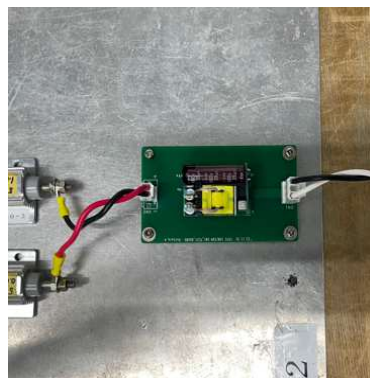
### 2. Radiated emission



## Conditions

Test : EMI  
Model Name : TEPS20F05

### 1.LINE CONDUCTION



### 2.RADIATED EMISSION

